leeun Classification

issue	Clas	SIIIC	iliOii

ORIGINAL

Application/Control N	о.

GIANOLA ET AL. Art Unit

INTERNATIONAL CLASSIFICATION

Applicant(s)/Patent Under Reexamination

Examiner AMY HE

	CLA	SS			SUBCLAS	S		CLAIMED				NON-CLAIMED						
324				158.1			G	0	1	R		31 / 28 (2006	.01.01)					
CROSS REFERENCE(S)			G	0	1	R		19 / 00 (2008	.01.01)									
GROSS REPERENCE(S)			н	0	4	В		17 / 00 (2006	.01.01)									
CLASS		SUBCLA	SS (ONE	SUBCLAS	S PER BL	OCK)		Π	Γ						Т			
324	78.11							Γ										
455	115.3																	
								_	_	_					_			
								_	_						+			
							_	_	┡						_	\perp		
							_	_	-	_				_	-			
		_					+	⊢	⊢	_					+	+		
	+	_					+	⊢	⊢					_	+	\vdash		
	+						+	┢	┢	-				+	+	+		
								_	_						1			
_										_						_		
	☐ Claims renumbered in the same order as presented by applicant ☐ CPA ☐ T.D. ☐ R.1.47																	
Final	Original	Final	Original	Final	Original	Final	Origina	el	Final		Original	Final	Original	Fin	al	Original	Final	Original
- 1	1		17	11	33			Т		T								
2	2		18	15	34			1		_								
5	3		19	19	35			4		_				1				
3	4		20					_		_				1				

NONE		Total Claims Allowed:				
(Assistant Examiner)	(Date)					
/AMY HE/ Primary Examiner.Art Unit 2831	04/22/2010	O.G. Print Claim(s)	O.G. Print Figure			
(Primary Examiner)	(Date)	1	6			